

SN54LS07, SN74LS07, SN74LS17 HEX BUFFERS/DRIVERS WITH OPEN-COLLECTOR HIGH-VOLTAGE OUTPUTS

SDLS021A, D3517, MAY 1990—REVISED AUGUST 1991

- Converts TTL-Voltage Levels to MOS Levels
- High Sink-Current Capability
- Input Clamping Diodes Simplify System Design
- Open-Collector Driver for Indicator Lamps and Relays
- Package Options Include “Small Outline” Packages, Ceramic Chip Carriers, and Standard and Ceramic 300-mil DIPs

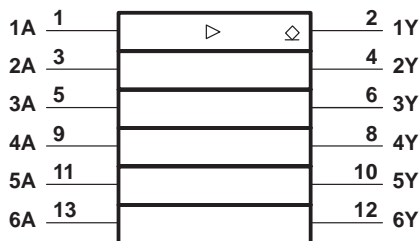
description

These monolithic hex buffers/drivers feature high-voltage open-collector outputs to interface with high-level circuits or for driving high-current loads. They are also characterized for use as buffers for driving TTL inputs. The 'LS07 has a rated output voltage of 30 V and the 'LS17 has a rated output voltage of 15 V. The maximum sink current is 30 mA for the SN54LS07 and 40 mA for the SN74LS07 and SN74LS17.

These circuits are compatible with most TTL families. Inputs are diode-clamped to minimize transmission-line effects, which simplifies design. Typical power dissipation is 140 mW and average propagation delay time is 12 ns.

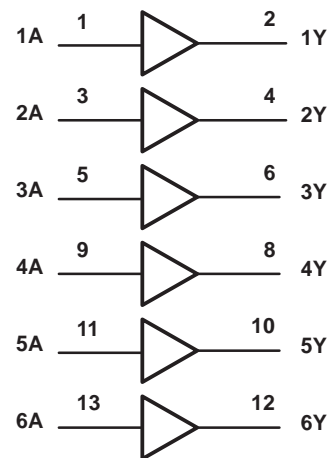
The SN54LS07 is characterized over the full military temperature range of -55°C to 125°C . The SN74LS07 and SN74LS17 are characterized for operation from 0°C to 70°C .

logic symbol†

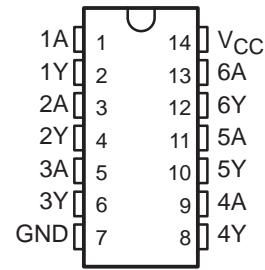


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for D, J, and N packages.

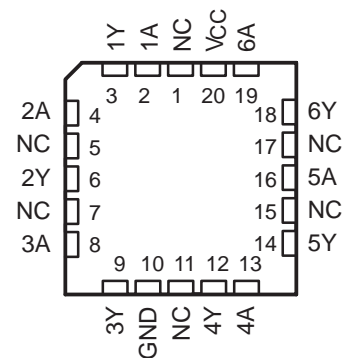
logic diagram (positive logic)



SN54LS07 . . . J PACKAGE
SN74LS07, SN74LS17 . . . D OR N PACKAGE
(TOP VIEW)



SN54LS07 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

SN54LS07, SN74LS07, SN74LS17
HEX BUFFERS/DRIVERS WITH
OPEN-COLLECTOR HIGH-VOLTAGE OUTPUTS

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†		SN54LS07			SN74LS07 SN74LS17			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	$V_{CC} = \text{MIN}$,	$I_I = -12 \text{ mA}$			-1.5			-1.5	V
I_{OH}	$V_{CC} = \text{MIN}$,	$V_{IH} = 2 \text{ V}$	'LS07, $V_{OH} = 30 \text{ V}$		0.25			0.25	mA
			'LS17, $V_{OH} = 15 \text{ V}$		0.25			0.25	
V_{OL}	$V_{CC} = \text{MIN}$,	$V_{IL} = 0.8 \text{ V}$	$I_{OL} = 16 \text{ mA}$		0.4			0.4	V
			$I_{OL} = \text{MAX}^{\S}$		0.7			0.7	
I_I	$V_{CC} = \text{MAX}$,	$V_I = 7 \text{ V}$			1			1	mA
I_{IH}	$V_{CC} = \text{MAX}$,	$V_I = 2.4 \text{ V}$			20			20	μA
I_{IL}	$V_{CC} = \text{MAX}$,	$V_I = 0.4 \text{ V}$			-0.2			-0.2	mA
I_{CCH}	$V_{CC} = \text{MAX}$				14			14	mA
I_{CCL}	$V_{CC} = \text{MAX}$				45			45	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

§ $I_{OL} = 30 \text{ mA}$ for SN54 series parts and 40 mA for SN74 series parts.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$ (see Note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_{PLH}	A	Y	$R_L = 110 \Omega$,	$C_L = 15 \text{ pF}$		6	10	ns
t_{PHL}						19	30	

NOTE 3: Load circuit and voltage waveforms are shown in Section 1 of *TTL Logic Data Book*, 1988.

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